Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/633,620	KATO ET AL.	
Examiner	Art Unit	
Quynh H. Nguyen	2614	

SEARCHED				
	<u> </u>	<u></u>		
Class	Subclass	Date	Examiner	
379	90.01 93.01 93.09 210.01 230	4/27/07	QN	
above	updated	12/10/2007	QN	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
Searched: East, USPGPub, USPAT, EPO, JPO	4/27/07	QN	
Inventor search in PALM database	4/27/07	QN	
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